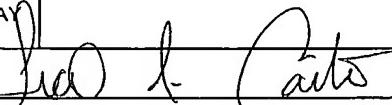
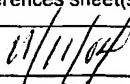


U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO. 249625US2DIV		SERIAL NO. New Application		
LIST OF REFERENCES CITED BY APPLICANT			APPLICANT Satoshi OHKAWA				
			FILING DATE Herewith		GROUP		
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
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JK	AT	1-269365	10/26/89	Japan (with English Abstract)			
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY	<input type="checkbox"/> Additional References sheet(s) attached					
Examiner			Date Considered 				
<small>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							